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| Notice of References Cited | Application/Control No. 10/785,602 | Applicant(s)/Patent Under Reexamination HACENA ET AL. | |
| | Examiner Michael Vu | Art Unit 2683 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------------|----------------|
| * | A | US-2002/0123365 | 09-2002 | Thorson et al. | 455/524 |
| * | B | US-2004/0017904 | 01-2004 | Williams et al. | 379/114.15 |
| * | C | US-2004/0147265 | 07-2004 | Kelley et al. | 455/445 |
| * | D | US-2004/0203580 | 10-2004 | Engelhart, Robert L. | 455/406 |
| * | E | US-2002/0118665 | 08-2002 | Cleveland et al. | 370/342 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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| | Q | | | | | |
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| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
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